

FORM PTO-1449 (modified)  
To: U.S. Department of Commerce  
(PW FORM PAT-1449)  
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Atty. Dkt. No.	M#	Client Ref.
	008312-0307572	T2MF-03S1166-1

**INFORMATION DISCLOSURE STATEMENT  
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Date: June 2, 2005

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Applicant: ARAI, Satoru et al.	
Appln. No.: 10/753,455	
Filing Date: January 9, 2004	
Examiner: Boris Chervinsky	Group Art Unit: 2835

**U.S. PATENT DOCUMENTS**

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
	CR					
	DR					
	ER					
	FR					
	GR					
	HR					

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
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	WR				
	XR				
	YR				
	ZR				
	AAR				

Examiner: *Boris L. Chervinsky* Date Considered: *6/24/05*

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